M-shaped Grating by Nanoimprinting: A Replicable, Large-Area, Highly Active Plasmonic Surface-Enhanced Raman Scattering Substrate with Nanogaps

Zhendong Zhu, Benfeng Bai, * Huigao Duan, Haosu Zhang, Mingqian Zhang, Oubo You, Qunqing Li, * Qiaofeng Tan, Jia Wang, Shoushan Fan, and Guofan Jin

1. Introduction

Surface plasmons (SPs) are collective oscillations of free-electron-density gas on a metal surface, which can funnel the electromagnetic (EM) field into subdiffraction volumes and thus have various applications in modulating light–matter interactions on the nanometer scale. [1,2] This energy-focusing effect is particularly promising in metallic nanostructures with tiny gaps, [1,3] such as V grooves, [4] nanoslots, [5] and self-similar chains of metal nanoparticles, [6] due to the strong localization of SPs in the nanogaps. When the SPs are localized in a sub-diffraction-limited tiny volume such as a nanoparticle [7] or nanocavity, [8] which is referred to as localized surface plasmons (LSPs), [9] the localized EM field may be greatly enhanced by orders of magnitude compared with the incident field (thus called the EM field “hot spot”). [10] The LSPs can be further steered via the intercoupling of various LSP resonance modes in complex metallic nanostructures such as plasmonic nanoshells [11] nanodimers, [5] self-similar...
chains of metal nanoparticles\textsuperscript{[12,13]} nanostars\textsuperscript{[14]} nanocrystals\textsuperscript{[15,16]} and nanogratings\textsuperscript{[17,18]} where the energy splitting of LSP resonant modes may be achieved by an appreciable change of, e.g., the nanogap size in the nanostructures, which leads to a pronounced shift of resonant frequencies. Therefore, the fine control of nanogaps\textsuperscript{[19,20]} or nanotips\textsuperscript{[21]} in such structures is crucial for generating, sustaining, and steering strong LSPs.

Field enhancement by orders of magnitude in the nanogaps of plasmonic nanostructures has been demonstrated and has been applied in, for example, material analysis\textsuperscript{[17,18]} optical rectification\textsuperscript{[19]} optical near-field characterization\textsuperscript{[21]} sensing\textsuperscript{[22]} nonlinear optics\textsuperscript{[23]} and high-sensitivity plasmonic rulers\textsuperscript{[24]} Stockman and co-authors\textsuperscript{[4]} proposed a cascaded self-similar nanoantenna chain that can significantly boost the enhancement−localization ratio of the LSPs. Cascaded field enhancement was achieved by using coupled gold nanoantennae of decreasing sizes. V-shaped nanogrooves and waveguides, another type of nanostructure with tiny gaps, are often used as light-concentration device\textsuperscript{[25−27]} in which the field can be strongly confined in the bottom of the V gaps and the EM energy can be transferred between the LSPs and the propagating SP waves. Based on these heuristic ideas and structures, several research groups\textsuperscript{[24,6,12,13]} have proposed many useful functional applications of V nanogrooves.

In the practical application of such plasmonic nanostructures, the key issues are the precise control of the nanogaps and the uniformity of the whole structure, which gives much challenge to nanofabrication\textsuperscript{[28−30]}. In previous works\textsuperscript{[28−30]} metallic nanostructures separated by tiny gaps were usually fabricated by using electron-beam lithography (EBL), which has a relatively low yield and high cost. Nanoimprinting lithography (NIL)\textsuperscript{[29]} is well known to be able to replicate nanostructures in a large area with relatively low cost, but for nanostructures with tiny gaps, the mother stamp for imprinting is difficult to fabricate. Nanosphere lithography\textsuperscript{[31−33]} is also a possible choice, but it is difficult to finely control and tune the nanogap size with this technique. With all these methods it is still challenging to achieve high-quality plasmonic nanostructures with both nanogaps and uniform large area. Therefore, a reliable and cost effective nanofabrication method is highly demanded in this regard.

Herein, we propose a simple M-shaped plasmonic nanograting structure, in which V-shaped nanogrooves with tens of nanometer width for sustaining strong LSPs can be readily realized uniformly in a large area. We develop a reliable technique based on room-temperature nanoimprinting lithography (RT-NIL)\textsuperscript{[34−36]} and anisotropic reactive-ion etching (RIE) to fabricate this structure. The EM field localization and enhancement in the V grooves of the M grating are analyzed by rigorous numerical simulation and are experimentally characterized by scanning near-field optical microscopy (SNOM). Finally, to demonstrate the potential application of this plasmonic nanostructure with tiny nanogaps, we employ the M grating as a substrate for surface-enhanced Raman spectroscopic (SERS) sensing. By probing Rhodamine 6G (R6G) molecules experimentally, the SERS enhancement factor is evaluated, and the existence of strongly localized field hot spots and the enhanced light−matter interaction in the substrate structure is verified.

2. Methods

2.1. The M-Grating Design

The M grating is designed to have an M-shaped profile so that it can generate relatively deep V grooves that have a width of only tens of nanometers between adjacent M shapes, by taking into account the anisotropic RIE fabrication process (see details in the Experimental Section). The schematic geometry of the M-grating is shown in Figure 1A; it has a period $d$, groove heights $h_1$ and $h_2$, nanogap width $w$, and geometrical vertex angles $\theta_1$ and $\theta_2$, $\theta_3$ is crucial as it determines the size of the nanogap and should be controlled carefully in the nanofabrication process. A gold film of thickness $t = 30$ nm is coated on the grating surface by using vacuum deposition. As a consequence of this deposition method, the film on the side wall of the M profile is usually thinner than that on the top surface (as shown in Figure 1A). In our numerical simulations, the refractive index of gold was taken from a dispersion model based on experimental data\textsuperscript{[37,38]}

In the design of the gold-film-coated M-grating, it is crucial to have tiny gaps (with $w =$tens of nanometers) between the adjacent M shapes to generate a strongly enhanced localized field inside the narrow V grooves with $\theta_3$ apex. We used the commercial software COMSOL 4.3\textsuperscript{®}, which is based on the finite-element method, to rigorously simulate the field distribution in the M grating. The grating is illuminated by a plane wave whose incident plane is perpendicular to the grating lines. Then both the structure and the incident light field are invariant along the $z$ axis (see Figure 1A), which can be treated as a two-dimensional problem in the simulation. The polarization of the incident field is denoted as TM (TE), if its magnetic (electric) field component is perpendicular to the incident plane. To excite LSPs effectively in the grating, the incident polarization is usually chosen as TM.

Without the loss of generality, we designed an M grating under the normal incidence of a TM-polarized plane wave with wavelength $\lambda = 785$ nm (which is a commonly used excitation wavelength in Raman spectroscopy). To get the most reliable simulation results, we created the grating geometry as close as possible to the practically fabricated samples, by rounding each sharp corner of the M profile by a radius of curvature of 10 nm (as shown in Figure 1A, and also see detailed discussion on the influence of curvature radius on the field localization in Section 1 of the Supporting Information). The electric-field amplitude of the incident light was normalized as $|\mathbf{E}_0| = 1$, so that the field enhancement factor can be evaluated directly by the amplitude of the excited-field distribution in the M grating as $|\mathbf{E}|/|\mathbf{E}_0| = 1$.

To produce pronounced LSP resonance at 785 nm, we have made a thorough numerical study of the field distribution in the M grating with respect to the change of nanogap size $w$. When $w$ is around 30 nm, the best field localization and enhancement results can be obtained, as shown in Figure 1B. To generate this size of nanogaps by using the
anisotropic RIE process (as explained in Section 2.2 and the Experimental Section), the period of the grating was chosen as $d = 200$ nm, which is one of the most crucial parameters for fabrication. The other geometrical parameters were: $h_1 = 120$ nm, $h_2 = 180$ nm, $\theta_1 = 85^\circ$, and $\theta_2 = 10^\circ$.

Figure 1B shows the simulated electric field distribution in this M grating under the normal incidence of TM-polarized light from the top side, where we can evidently see the pronounced field localization and enhancement (with an enhancement factor up to 700) in the whole open area of the V groove. This field localization and enhancement is generated by the efficient coupling of the LSPs confined on the two adjacent corners of the M-grating profile due to their small spacing separated by the V groove. This is the same principle as the LSP coupling reported in many previous works,\textsuperscript{[4,7,13,16,20]} in which the enhanced field is generated in the tiny gaps between metallic nanoparticles due to their strong intercoupling with decreased spacing. This gap effect\textsuperscript{[2]} is of central importance to the performance of many plasmonic nanosensors. To validate this LSP coupling mechanism, we calculated the field distribution in the same M grating under TE illumination (as shown in Figure 1C). Clearly, the field can be localized and enhanced in both grooves, but the field enhancement factor depends on the vertex angle and depth of the groove significantly: with narrower and deeper grooves, the field is confined better and enhanced more significantly, even though the field enhancement factor in both structures (the maximum is about 70 in Figure 2B and 4 in Figure 2A) is much smaller than that in the M grating in Figure 1B. On the other hand, in the deeper and narrower grooves in Figure 2B, the LSPs exhibit a higher order cavity mode,\textsuperscript{[8,39,40]} unlike that in the M grating. All these results imply that the remarkable field enhancement in the nanogap of M grating stems from the strong coupling of the LSP states supported by the two individual V grooves, as presented in Figures 2A and 2B. Owing to the polarization and momentum matching under TM illumination, the dipolar oscillations of the LSPs in the two grooves can couple with each other strongly. In other words, the LSPs in the shallow groove can modulate the LSPs in the deep groove. Consequently, a new LSP resonance mode is generated in the M grating (as shown in Figure 1B)
which is significantly different from the LSP mode in each individual V groove.

To better understand this coupling mechanism, we also simulated two additional grating structures under the same incidence condition as the M grating (TM polarization, normal incidence, \( \lambda = 785 \text{ nm} \)), as shown in Figures 2C and 2D. Figure 2C is a rectangular nanograting with \( d = 200 \text{ nm} \), groove depth \( h = 180 \text{ nm} \), gold film (only on top of the grating ridge and at the bottom of the groove) thickness \( t = 30 \text{ nm} \), and a 30-nm-wide rectangular nanogap. Clearly, there is almost no field localization and enhancement in the whole structure (where the maximum field enhancement factor is no more than 2). In this case, there is only one nanogap in one period so that no intercoupling between nanogaps can be generated; on the other hand, the rectangular nanogap shows much weaker field confinement than the V groove.

Figure 2D shows another type of M-shaped nanograting (named M1 grating hereafter), of which the profile is fitted according to one of our fabricated samples. The main grating parameters such as the period and the gold film thickness are the same as those of the M grating in Figure 1, but the grating profile is modified so that the nanogaps are almost rectangular instead of V shaped. The widths of the two nanogaps in a period are 30 nm and 60 nm, and the heights are \( h_1 = 50 \text{ nm} \) and \( h_2 = 180 \text{ nm} \). The simulation results show that the EM field can still be localized in the nanogaps, but the intensity of the localized field is much weaker than in Figure 1B. The maximum field enhancement factors in the narrower gap and in the wider groove are about only 40 and 25, respectively. This result shows again that the field localization in the rectangular nanogap is much weaker than that in the V groove and the intercoupling of the LSPs in the two rectangular nanogaps is also much weaker.

According to the above analyses, we may conclude that the strong field localization in the narrow V-shaped nanogap and the intercoupling of LSPs in the two adjacent grooves are the key factors to generate the strongly localized and enhanced EM field. The intercoupling is strongly dependent not only on the nanogap size but also on its shape, so that the V-shaped grooves (in Figure 1B) behave better than the rectangular grooves (in Figure 2D). Therefore, fine control of the V-shaped nanogaps is crucial for generating and sustaining an enhanced localized EM field.

### 2.2. Fabrication of the M Grating

We have developed a RT-NIL technique to fabricate the M grating. The whole fabrication process is sketched in Figure 3A. Firstly, two layers of photoresists, including a 350-nm-thick polymethylmethacrylate (PMMA) bottom layer and a 200-nm-thick hydrogen silsequioxane (HSQ) top layer, were spin-coated sequentially onto a cleaned gallium nitride (GaN) substrate. Then, the RT-NIL process was operated by using a rectangular nanograting stamp with period 100 nm, grating line-width 50 nm, and groove depth 250 nm, which was fabricated by standard EBL on a quartz substrate. After demolding, an RIE process was performed with pure CF\(_4\) to remove the residual HSQ in the imprinted grooves. Then, with the HSQ mask, the PMMA layer was etched through by RIE with pure O\(_2\) plasma. Afterwards, with the nanostructured HSQ/PMMA bilayer mask, another anisotropic RIE
A process was employed to etch the underneath GaN substrate in \( \text{O}_2 \) 10/\( \text{Ar} \) 10/\( \text{Cl}_2 \) 48/\( \text{CF}_4 \) 26 sccm plasma; this is the crucial process to form the M-grating profile. Finally, after removing the residual resists by bathing the structured samples in acetone, a desired thickness of metal film (e.g., a 30-nm thick gold film as we used here) was deposited onto the surface of the nanostructure to achieve the M grating.

In the above procedure, the formation of the M-shaped profile is crucial; this is controlled by anisotropic RIE. In this process, since the HSQ layer was cured gradually from the top down by \( \text{O}_2 \) plasma, the PMMA layer received a lateral etching during the \( \text{Ar} \) plasma blasting to form the raster gate lines on the GaN substrate. At about the halfway point of the etching process, each two adjacent PMMA raster gate lines collapsed into each other because they could no longer hold under the \( \text{Ar} \) and \( \text{O}_2 \) plasma bombing; the collapse direction was predominantly determined by the interface tension of the polymeric raster gate lines. The gradual collapse procedure was determined by the power and operating time of \( \text{O}_2 \) and \( \text{Ar} \) plasma bombing. During this process, the GaN substrate was etched nonuniformly: in the area covered by the collapsed line pairs, the etching speed was relatively slower; while in the area outside the collapsed line pairs, the etching speed was faster. After the line pairs completely collapsed into each other, the etching was stopped in the regions underneath the photoresist line pairs. However, the etching of the uncovered regions continued until the operating time was over. In this way, a nanograting with an M-shaped profile was gradually formed.

The structure parameters of the fabricated samples were measured from the scanning electronic microscope (SEM, FEI Serion2000) images of the M grating before and after the gold-film coating (as shown in Figures 3C and 3D, respectively). They are very close to the designed parameters. Figure 3B shows the SEM image of an M-grating sample right after the anisotropic RIE etching and before the removal of the bilayer resist, which verifies the etching mechanism stated above. The V-groove angles can be controlled by tuning the dry-etching parameters. For example, by changing the etching recipe to \( \text{Ar} \) 5/\( \text{Cl}_2 \) 48/\( \text{CF}_4 \) 10 sccm, we can obtain...
an M1-grating profile (as shown in Figure 3E), where the nanogap widths are 30 nm and 60 nm and the groove heights are $h_1 = 50$ nm and $h_2 = 180$ nm (corresponding to the simulated structure in Figure 2D). A detailed discussion on profile control to generate M or M1 grating is presented in Section 3 of the Supporting Information.

The proposed method is suitable for fabricating large-area M-grating substrates while maintaining relatively good uniformity. In our experiment, the fabricated sample has an operating area as large as 10 cm$^2$, as shown in Figure S2. A detailed discussion on the fabrication of large-area and uniform SERS substrates is given in Section 2 of the Supporting Information.

### 3. Experimental Study of the Field Enhancement in the M Grating

#### 3.1. Near-Field Characterization

To investigate the field localization and enhancement in the M grating experimentally, a SNOM (NT-MDT NTEGRA, Russia) equipped with an aperture optical fiber probe was used to spatially map the near-field distribution on the surface of the M grating. Figure 4A shows a schematic of the transmission-type SNOM setup. The M-grating sample, which was mounted on a piezo-scanner table, was illuminated normally by using a collimated He–Ne laser beam of 633-nm wavelength from the back side. At normal incidence we had to illuminate the sample from the back side (not the top side) to avoid mechanical interference between the incident light beam and the fiber probe; a 633 nm laser (instead of a 785 nm one) was used as the light source to illuminate the sample because the light is visible and can facilitate the adjustment of the optical setup. Due to these differences from our theoretical simulation, we should re-evaluate the field localization in the M grating in this case. The simulated field distribution in the same M grating as in Figure 1B but under the normal illumination of a TM-polarized plane wave of 633-nm wavelength from the back side is shown in Figure 1D. The field distribution in general is similar to that in Figure 1B, except that the field intensity is weaker (with an enhancement factor up to 350) and a higher order cavity mode appears in the V groove. This result is because the LSP resonance usually exists in a relatively broad wavelength range, so that similar field localization and enhancement effect can still be observed at 633-nm wavelength. Since the field distributions at these two wavelengths are greatly similar and only a little different in strength, we can use the 633-nm laser to characterize the field localization in the M grating.

An aperture fiber probe was located on the opposite side of the sample to collect the near-field signal (as shown in Figure 4A). The field on the M-grating surface was measured by a photomultiplier tube (PMT). The intensity distribution of the near-field optical signal was mapped by scanning the probe tip over the central region of the M grating. By using this technique, the topography of the grating sample and the near-field distribution image can be obtained simultaneously, as shown in Figures 4B and 4C, respectively. Due to the limited spatial resolution of the SNOM probe, the topography in Figure 4B does not show much detail of the M profile. However, the positions of the grating ridges and grooves (bright and dark regions in Figure 4B, respectively) are clearly demonstrated. The correspondence between the topography of the M-grating profile and the near-field distribution on the grating surface is clearly seen by comparing Figures 4B and 4C. As indicated by the blue boxes in Figure 4C, the EM field is mainly localized in the open area of the narrow V groove and is greatly enhanced therein (see the bright regions, where the PMT signal intensity is up to 50 mV). Moreover, the field on the two edges of the narrow V groove is stronger than that in the middle of the V groove. All these features correspond well with the numerical simulations in Figure 1B. Therefore, it is experimentally verified that strong field localization and enhancement can exist in the V-shaped nanogaps of the M grating, as predicted by the numerical simulations.

#### 3.2. SERS Experiment

As a demonstration of the potential application of the proposed M grating, the sample was used as a SERS substrate...
Figure 5. Measured Raman spectra of the R6G molecules on different substrates. A) The reference Raman spectrum collected from the unpatterned gold film. B) and C) are the SERS spectra measured on the M1 grating under TE and TM illuminations, respectively. D) and E) are the same as B) and C), but for the M grating. The 1365 cm\(^{-1}\) band is the characteristic vibration wavenumber of the R6G molecules.

for probing R6G molecules (bulk concentration=0.1 µm). The R6G molecules were dosed onto the M-grating surface. The back-scattered Raman spectra were recorded by using a LabRam microRaman system (Jobin-Yvon/ISA HR) equipped with a thermoelectrically cooled charge-coupled device (CCD) array detector and an Olympus BH-2 100x short-focal-length objective lens (nominal numerical aperture=0.85). A continuous-wave GaAs laser (Spectra Physics 3900s) of 785-nm wavelength and output power of 0.6 mW was used to excite the samples.

The SERS spectra of the R6G molecules were collected in the Raman shift range of 200–2000 cm\(^{-1}\), in one acquisition and in an accumulation time of 10 s. The reference spectrum was collected from the unpatterned area (i.e., a flat surface with gold film only) on the same device, in five acquisitions and with the accumulation time of 10 s. All the data were fitted from the baseline-removed Raman spectra using a Gaussian–Lorentzian line shape.

Thus, according to Equation (1), the SERS EF of the M-grating under TM illumination can be estimated to be as high as 5x10^5. This experimental EF value is comparable with but a little smaller than the theoretically estimated EF, which is calculated to be EF = |E|^4 / |E_0|^4 = 10^{10} [2]. The difference can be attributed to the experimental errors and theoretical estimation errors. In contrast, the experimental EF value of the M1 grating is only 5x10^3.

Furthermore, it is meaningful to evaluate the SERS sensitivity of the M-grating substrate. For this aim, we have experimentally investigated the detection limit of the R6G molecules (see details in Section 4 in the Supporting Information). By measuring R6G solutions of various concentrations, the lowest concentration of R6G solution that can produce effective Raman signal from the M-grating substrate was determined as 0.02 µm, which can act as a gauge of the SERS sensitivity of the device.

These SERS experiments provide concrete evidence that the M grating has much better SERS performance than the reference M1 grating, owing to the much stronger field localization and significant enhancement in the V-shaped nanogaps. Therefore, the M grating has great potential to be used as a low-cost, replicatable, high-performance active substrate for SERS applications.

4. Conclusion

We have proposed and presented the design and fabrication of a simple M-shaped nanograting with tiny gaps of tens of nanometers. Mediated by the localization and intercoupling of LSPs, strong field amplitude enhancement up to 700-fold can be generated in the opening area of the narrow V grooves, thanks to the special M-shaped profile. A nanofabrication technique based on RT-NIL and anisotropic RIE has enhanced localized field and light–matter interaction on the M-grating surface.

To quantitatively evaluate the SERS performance of the M-grating substrate, we calculated the SERS enhancement factor (EF) of the probing R6G molecules using Equation 1 [29]:

\[
EF = \frac{I_{\text{SERS}}}{I_{\text{bulk}}} \frac{N_{\text{surf}}}{N_{\text{bulk}}} \approx \frac{|E|^4}{|E_0|^4} \approx 10^{10}.
\]
been developed to fabricate this novel plasmonic device with well-controlled nanogap size and shape, which is cost effective, reliable, and suitable for fabricating large-area nanostructures. The field localization and coupling mechanisms were analyzed theoretically by using numerical simulation and characterized experimentally by using SNOM measurements. This M-grating device has excellent prospects in many plasmonic applications such as ultrasensitive sensing of chemical and biological substances. As a demonstration of the potential application, the M grating was used as a SERS substrate for probing R6G molecules. Experimentally, an average SERS enhancement factor as high as \(5 \times 10^8\) was achieved, verifying the greatly enhanced light–matter interaction on the surface of the M grating.

5. Experimental Section

**M Grating Fabrication:** A quartz stamp patterned with linear rectangular grating with period of 100 nm and duty cycle of 0.5 was fabricated by using EBL. Then the nanoimprinting resists HSQ (XR-1541–006, Dow Coming, USA) and PMMA (MicroChem, PMM A950A4) were spin-coated onto the GaN substrate to the appropriate thickness (determined by mold depth, duty cycle, and period), baked on a hotplate (70 °C, 5 min) to remove residual solvent, and imprinted with a custom-built nanoimprinter (50 psi, 5 min, at room temperature). After separation of the mold and substrate, the residual HSQ was removed in Cl₂ plasma (40 sccm, 2 Pa, 40 W, 2 min) and the bottom PMMA layer was etched with O₂ plasma (48 sccm, 26 Pa, 70 W, 30 s). The pattern was transferred into the GaN substrate by using RIE (M grating: 48/26/10/10 sccm Cl₂/CF₄/O₂/Ar, 100 W, 16 Pa, 2 min; M1 grating: 48/10/5 sccm Cl₂/CF₄/Ar, 40 W, 26 Pa, 2 min). The final resist was removed by soaking in acetone and using a low-power ultrasonic bath, rinsed with methanol and isopropanol (IPA), and dried using a steady stream of N₂.

**Metal Deposition:** Metal deposition was performed by using an electron beam evaporator (L-600EK Evaporation System, ANELVA, Japan). A 30-nm-thick gold film was deposited onto the sample at the operating pressure of \(5 \times 10^{-3}\) Pa. The temperature of the sample chamber was kept at 20 °C during the entire evaporation process, with the sample holder rotating at a rate of 40 rpm to ensure the uniformity of deposition. A general adhesive layer such as Cr or Ti was not necessary.

**Numerical Simulation:** Numerical simulations were performed on a workstation by using the commercial software COMSOL 4.3© based on the finite-element method. To obtain a EM field distribution as close as possible to the practical situation, we defined the M profile by rounding each sharp corner by a radius of curvature of 10 nm. Periodic boundary condition was used in the x direction to simulate an infinite array of periodic M grating. Perfectly matched layer boundary conditions were executed in the y direction. The mesh size used in the simulation regions was 1 nm. The gratings were illuminated by a plane wave propagating along the y direction. The total electric field amplitude was calculated to generate the field distribution in the structures. The refractive indices of gold and GaN were taken from a dispersion model based on experimental data and the Palik database, respectively. \(^{37,38}\)

---

**Supporting Information**

Supporting Information is available from the Wiley Online Library or from the author.

**Acknowledgements**

We acknowledge support by the National Natural Science Foundation of China (Projects no. 61227014, 11004119, and 61161130005) and the Chinese National Science and Technology Plan 973 with grant no. 2007CB935301.

---

M-shaped Grating by Nanoimprinting: A Replicable, Large-Area, Highly Active Plasmonic Surface-Enhanced